

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/849,794	WEE ET AL.	
Examiner		Art Unit		Page 1 of 1
Brandon S. Hoffman		2136		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,275,531	08-2001	Li, Weiping	375/240.12
	B	US-6,782,550	08-2004	Cao, Yousheng	725/39
	C	US-5,914,751	06-1999	Korth, Hans-Erdmann	375/240.12
	D	US-6,580,754	06-2003	Wan et al.	375/240.01
	E	US-6,578,150	06-2003	Luyster, Frank C.	713/200
	F	US-6,553,072	04-2003	Chiang et al.	375/240.25
	G	US-5,742,892	04-1998	Chaddha, Navin	725/146
	H	US-6,529,552	03-2003	Tsai et al.	375/240.05
	I	US-6,505,299	01-2003	Zeng et al.	713/160
	J	US-6,493,036	12-2002	Fernandez, Gustavo A.	348/561
	K	US-5,319,707	06-1994	Wasilewski et al.	380/212
	L	US-6,385,596	05-2002	Wiser et al.	705/51
	M	US-6,351,538	02-2002	Uz, K. Metin	380/201

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.